Multi-Chroic Detectors for Observing the Cosmic Microwave Background

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Journée des Doctorants APC 15-11-2017

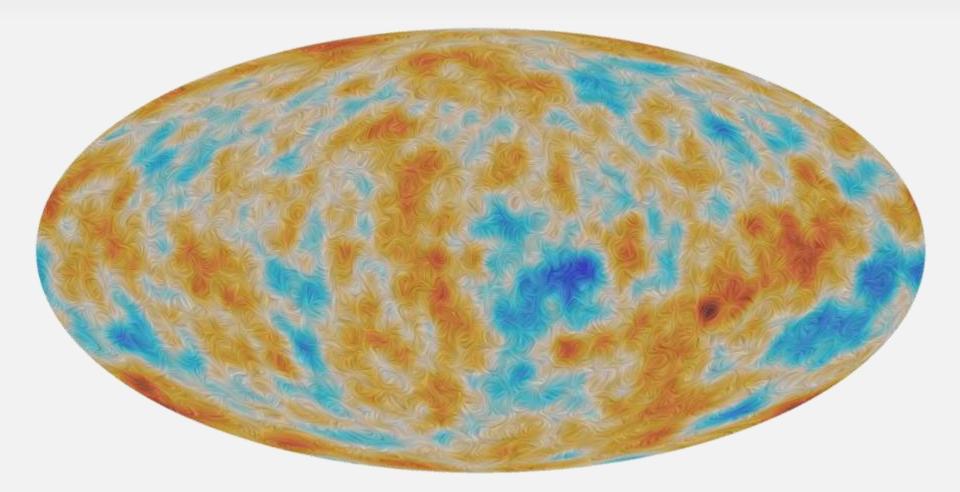
Supervisor: Michel Piat



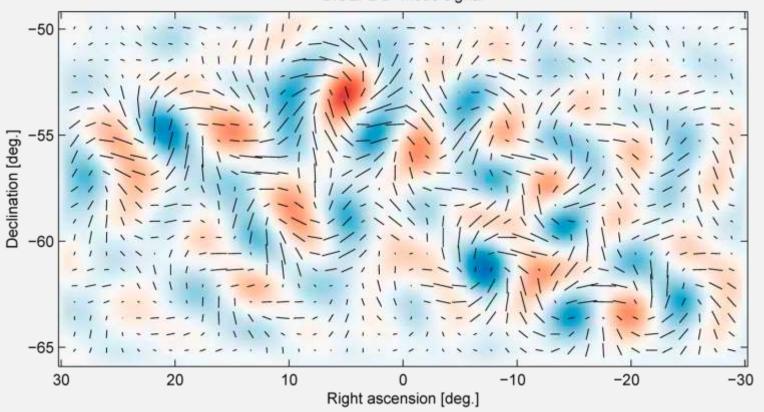




- Motivation
- Kinetic Inductance Detectors (KIDs)
- Antenna-Coupled LEKID



CMB as detected by ESA's Planck Space Telescope Approximately the 10% of CMB is polarized

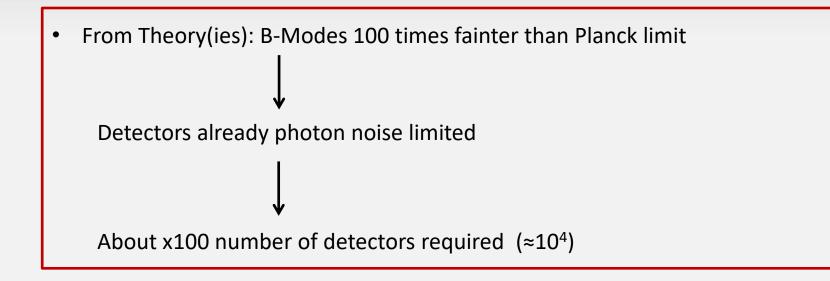


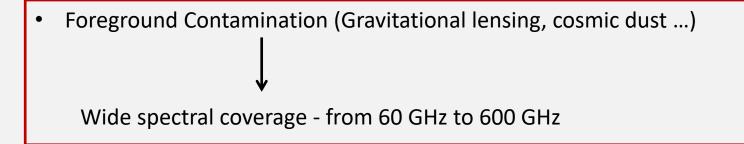
BICEP2 B-mode signal

TENSOR to SCALAR ratio from Planck (and Bicep2)

 $r < 10^{-1}$

Future CMB Observations: Technological Challenges





Antenna Coupling:

- Improving the area filling efficiency
- Polarization sensitive pixels

BOLOMETERS

- Photon noise limited
- Widely used on CMB telescopes
- High TRL
- Complex to fabricate (expensive)
- Complex readout (for large array)

KINETIC INDUCTANCE DETECTORS

- Naturally multiplexed
- Only planar structures (less expensive)
- Short time constant
- Less sensitive to temperature fluctuations
- Vibration insensitive
- Lower TRL
- Room temperature electronics
- Recent technology

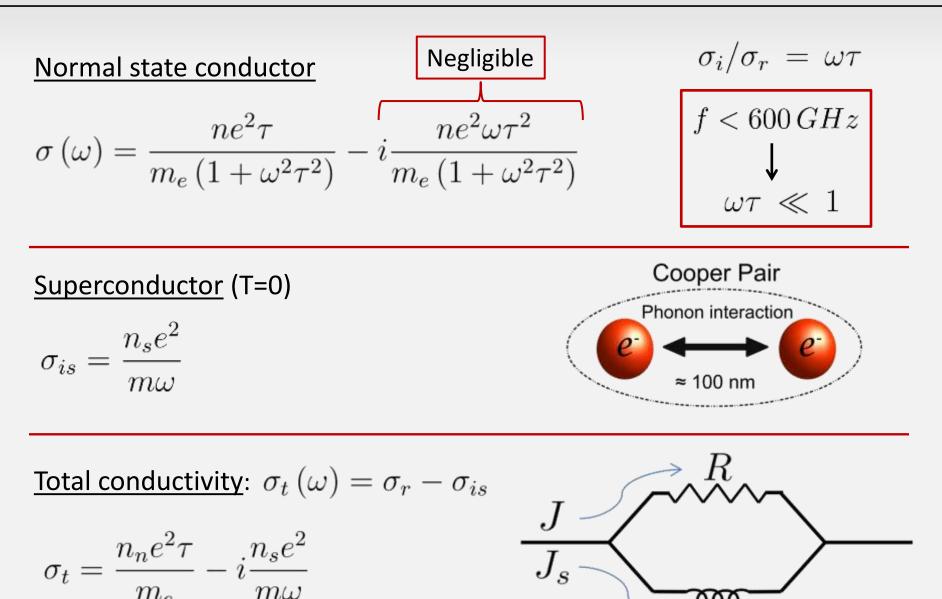


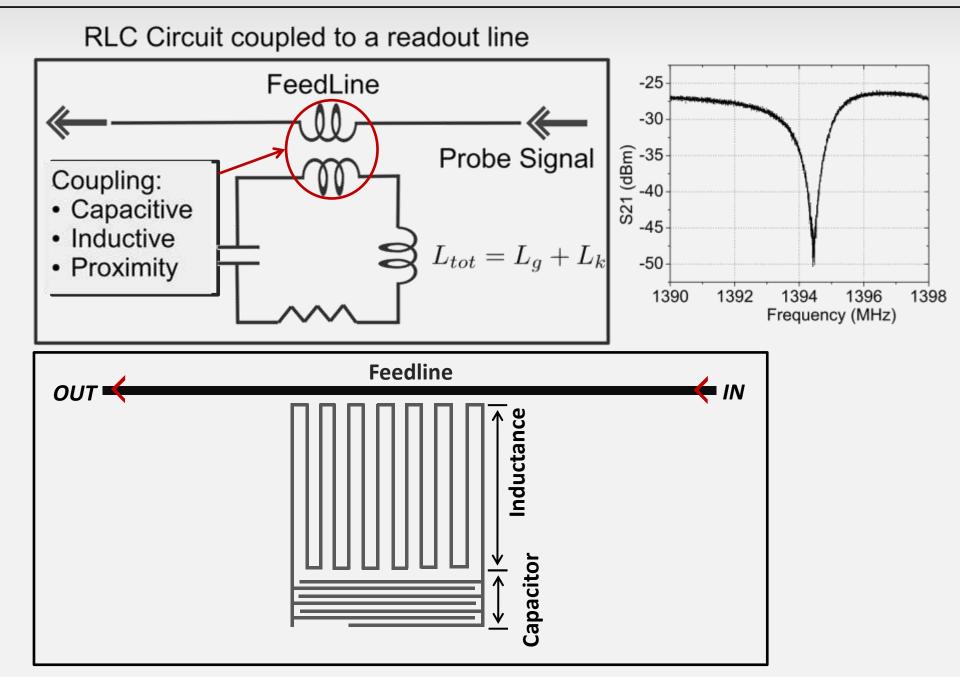
Credit: QUBIC collaboration

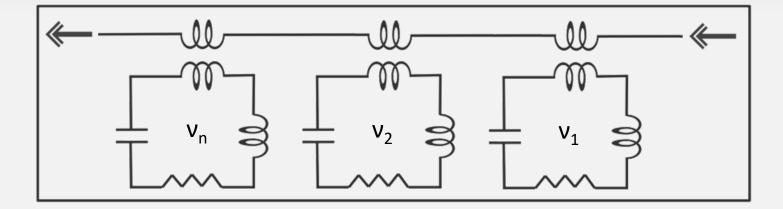


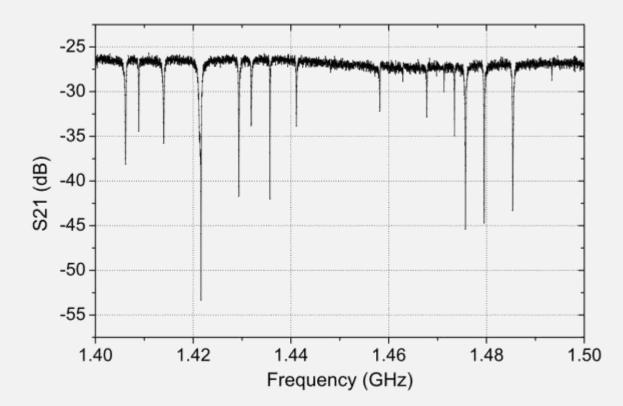
Credit: Nika2 collaboration

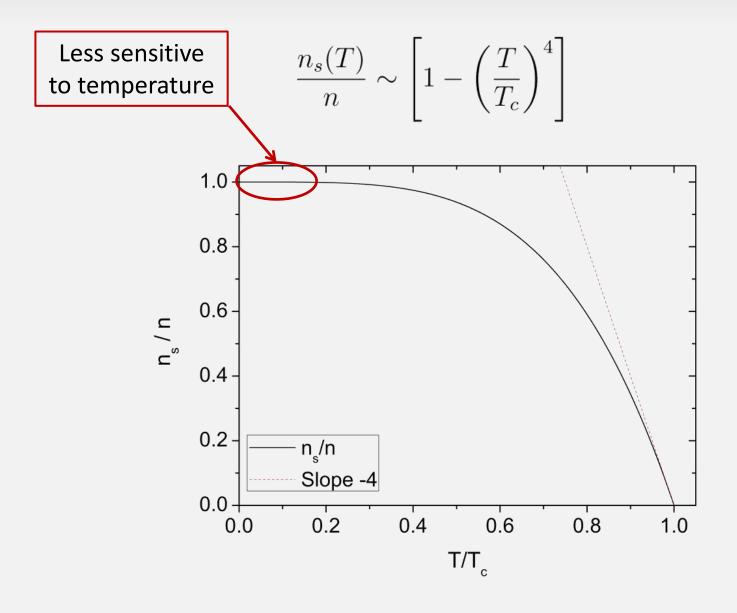
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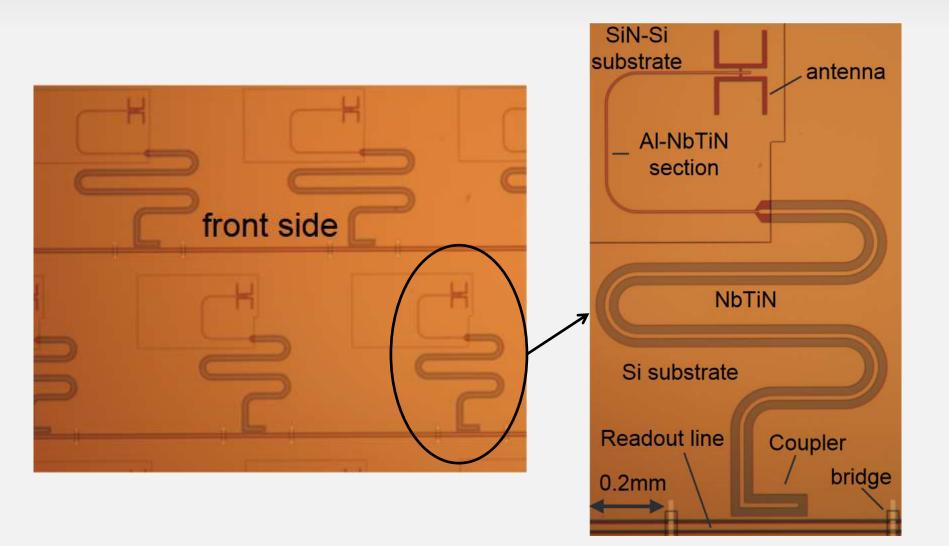




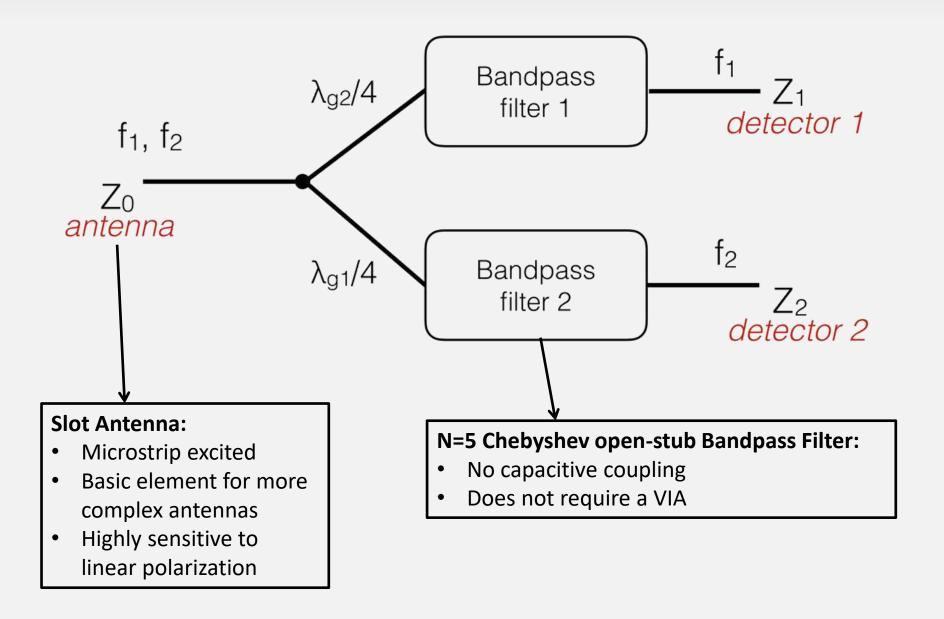
$2\Delta(0) \approx 3.52 \, k_b T_c$

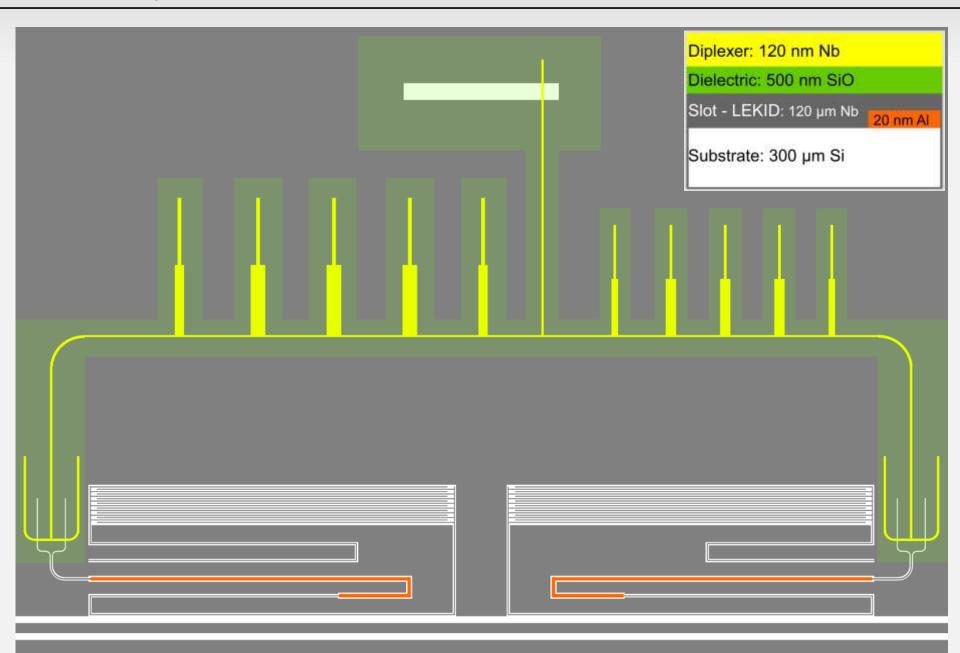
MINIMUM FREQUENCY DETECTABLE			
CONDUCTOR	$T_c [K]$	$2\Delta \ [meV]$	$\nu_{min} [GHz]$
TITANIUM	0.39	0.12	28.6
GALLIUM	1.1	0.33	80.7
Aluminium	1.2	0.36	88
Indium	3.4	1.03	249.4
TIN	3.7	1.12	271.4
Mercury	4.2	1.27	308
LEAD	7.2	2.19	528
NIOBIUM	9.3	2.82	682.1

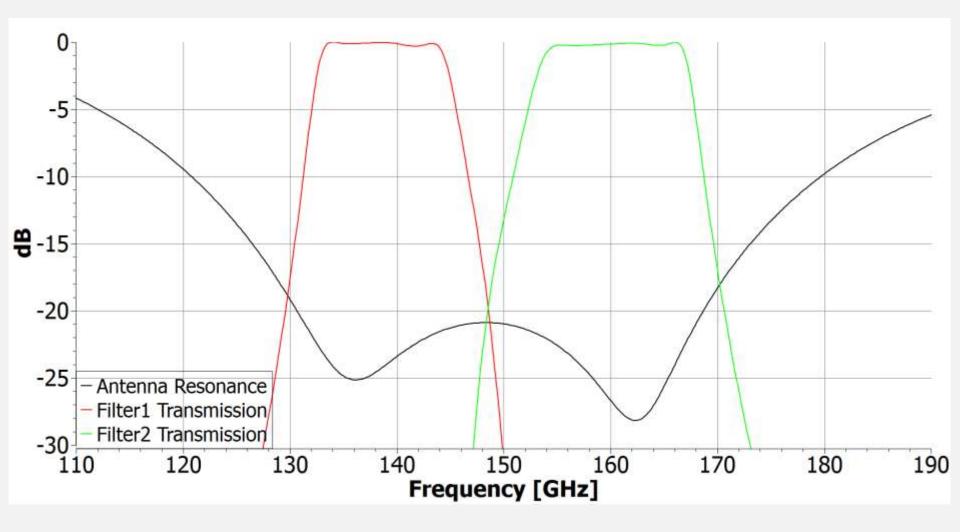
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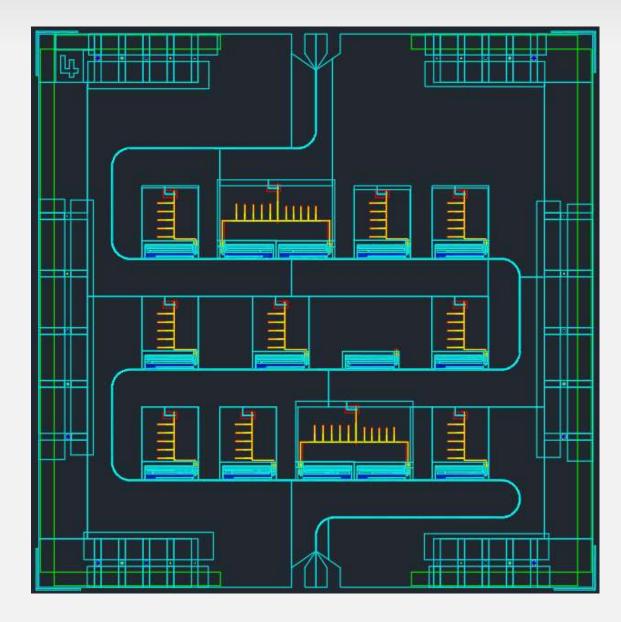


S. Yates et al. (2017)

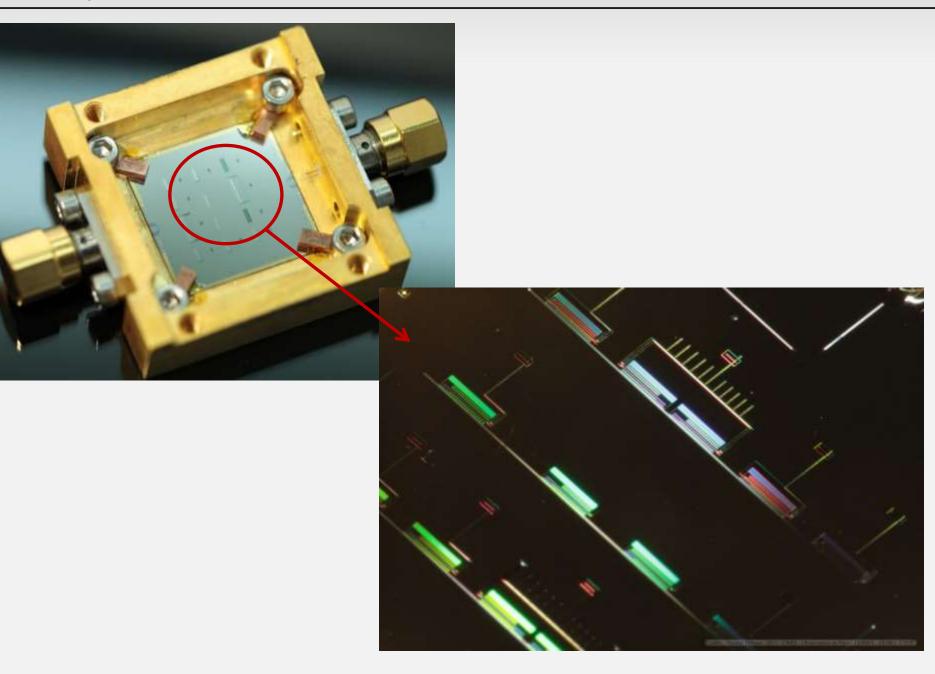




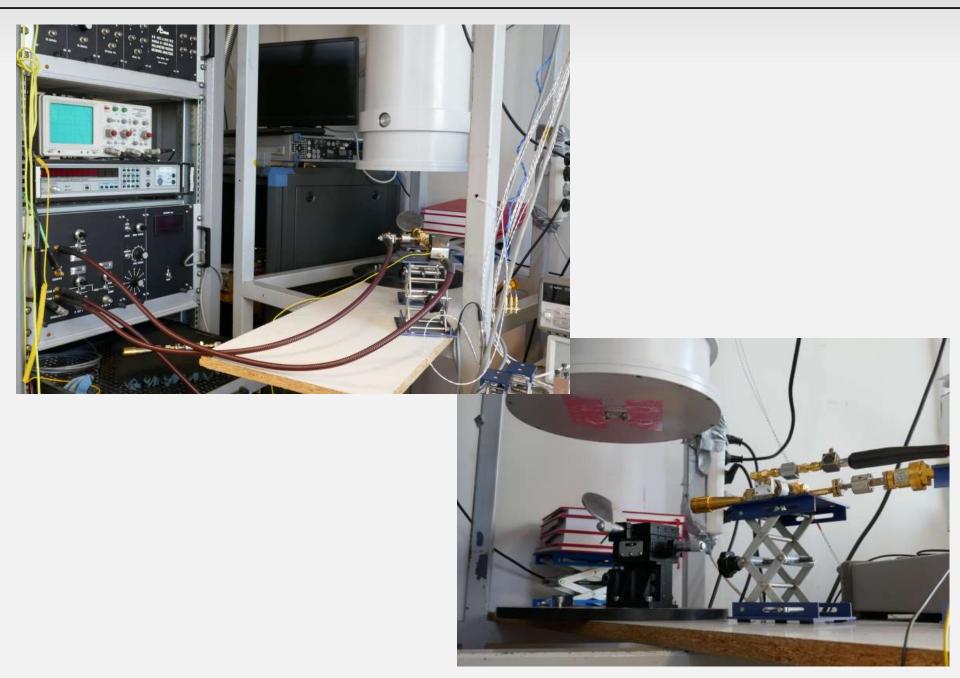




Test Chip 14 Detectors



Tests at APC



DESIGN

- Polarization sensitive slot antenna with 35% bandwidth
- Open-Stub Bandpass filter diplexer at 140 GHz and 160 GHz
- Lumped Element Kinetic Inductance Detector coupling

FABRICATION STATUS AND TESTS

- Five chips fabricated at Paris Observatory GEPI
- Preliminary tests at APC down to 300 mK currently ongoing
- Tests down to 100 mK at Institut NEEL to arrange

This project is part of an ESA TRP to develop pixels for future CMB focal planes.